

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination MIYANO ET AL.	
		Examiner Faye Polyzos	Art Unit 2884	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,449,787 A	05-1984	Burbo et al.	313/524
*	B	US-5,089,914 A	02-1992	Prescott, John A.	359/815
*	C	US-5,604,346 A	02-1997	Hamrelius et al.	250/252.1
*	D	US-5,805,120 A	09-1998	Yamada et al.	345/7
*	E	US-5,838,489 A	11-1998	Erdmann, Matthias	359/357
*	F	US-5,949,582 A	09-1999	Coombs, Christopher E.	359/630
*	G	US-6,476,391 B1	11-2002	Zhang, Evan Y. W.	250/330
*	H	US-6,720,878 B2	04-2004	Jumpertz, Werner	340/573.1
*	I	US-2002/0030163 A1	03-2002	Zhang, Evan Y.W.	250/330
*	J	US-6,023,288 A	02-2000	Coombs et al.	348/64
*	K	US-6,606,114 B1	08-2003	Gordon et al.	348/64
*	L	US-6,560,029 B1	05-2003	Dobbie et al.	359/631
*	M	US-4,996,981	03-1991	Elenewski et al.	128/201.15

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.